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Understanding [Embedded - FPGAs (Field Programmable Gate Array)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details

Product Status	Active
Number of LABs/CLBs	864
Number of Logic Elements/Cells	3888
Total RAM Bits	49152
Number of I/O	176
Number of Gates	150000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	256-BGA
Supplier Device Package	256-FBGA (17x17)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc2s150-6fg256c

General Overview

The Spartan-II family of FPGAs have a regular, flexible, programmable architecture of Configurable Logic Blocks (CLBs), surrounded by a perimeter of programmable Input/Output Blocks (IOBs). There are four Delay-Locked Loops (DLLs), one at each corner of the die. Two columns of block RAM lie on opposite sides of the die, between the CLBs and the IOB columns. These functional elements are interconnected by a powerful hierarchy of versatile routing channels (see Figure 1).

Spartan-II FPGAs are customized by loading configuration data into internal static memory cells. Unlimited reprogramming cycles are possible with this approach. Stored values in these cells determine logic functions and interconnections implemented in the FPGA. Configuration data can be read from an external serial PROM (master serial mode), or written into the FPGA in slave serial, slave parallel, or Boundary Scan modes.

Spartan-II FPGAs are typically used in high-volume applications where the versatility of a fast programmable solution adds benefits. Spartan-II FPGAs are ideal for shortening product development cycles while offering a cost-effective solution for high volume production.

Spartan-II FPGAs achieve high-performance, low-cost operation through advanced architecture and semiconductor technology. Spartan-II devices provide system clock rates up to 200 MHz. In addition to the conventional benefits of high-volume programmable logic solutions, Spartan-II FPGAs also offer on-chip synchronous single-port and dual-port RAM (block and distributed form), DLL clock drivers, programmable set and reset on all flip-flops, fast carry logic, and many other features.
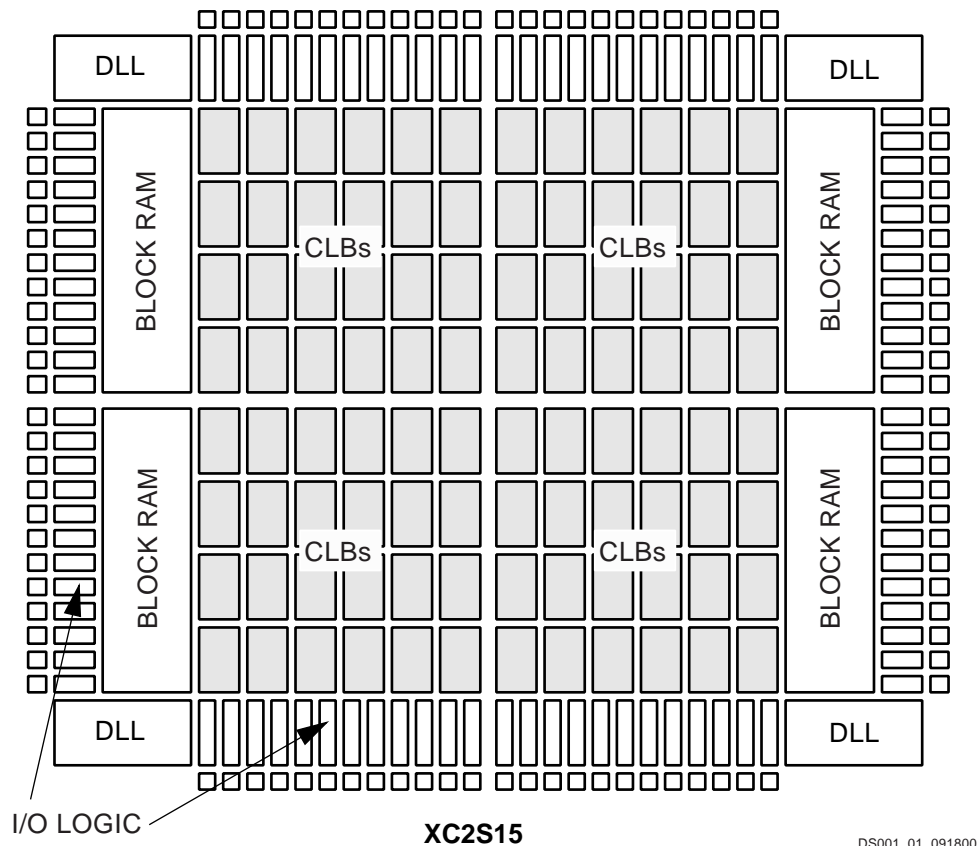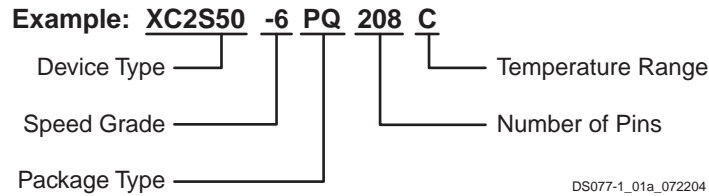

Figure 1: **Basic Spartan-II Family FPGA Block Diagram**
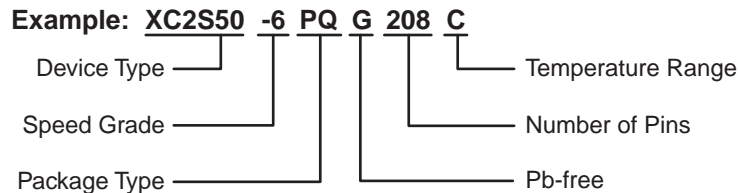
Ordering Information

Spartan-II devices are available in both standard and Pb-free packaging options for all device/package combinations. The Pb-free packages include a special "G" character in the ordering code.

Standard Packaging

Example: XC2S50 -6 PQ 208 C

Device Type
Speed Grade
Package Type
Temperature Range
Number of Pins

DS077-1_01a_072204

Pb-Free Packaging

Example: XC2S50 -6 PQ G 208 C

Device Type
Speed Grade
Package Type
Temperature Range
Number of Pins
Pb-free

DS077-1_01b_072204

Device Ordering Options

Device	Speed Grade		Number of Pins / Package Type		Temperature Range (T_J)	
XC2S15	-5	Standard Performance	VQ(G)100	100-pin Plastic Very Thin QFP	C = Commercial	0°C to +85°C
XC2S30	-6	Higher Performance[1]	CS(G)144	144-ball Chip-Scale BGA	I = Industrial	−40°C to +100°C
XC2S50			TQ(G)144	144-pin Plastic Thin QFP		
XC2S100			PQ(G)208	208-pin Plastic QFP		
XC2S150			FG(G)256	256-ball Fine Pitch BGA		
XC2S200			FG(G)456	456-ball Fine Pitch BGA		

Notes:
1. The -6 speed grade is exclusively available in the Commercial temperature range.

Device Part Marking

Device Type
Package
Speed
Operating Range

XILINX®
SPARTAN®
XC2S50™
PQ208AFP0025
A1134280A
6C

Date Code
Lot Code

Sample package with part marking
for XC2S50-6PQ208C.
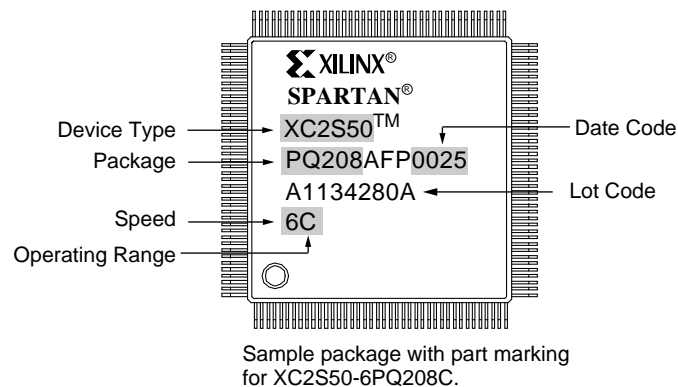
ds001-1_02_090303

Local Routing

The local routing resources, as shown in Figure 6, provide the following three types of connections:

- Interconnections among the LUTs, flip-flops, and General Routing Matrix (GRM)

- Internal CLB feedback paths that provide high-speed connections to LUTs within the same CLB, chaining them together with minimal routing delay

- Direct paths that provide high-speed connections between horizontally adjacent CLBs, eliminating the delay of the GRM
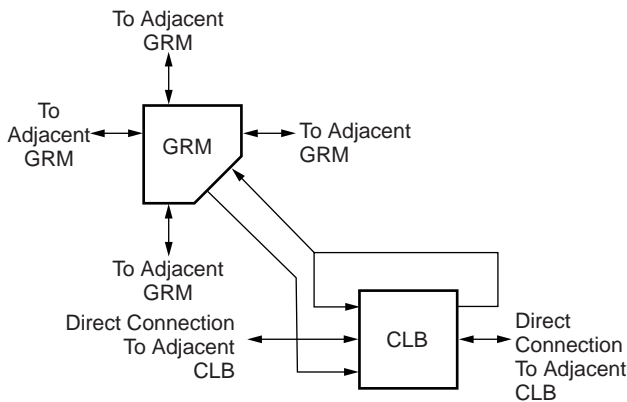
DS001_06_032300

Figure 6: **Spartan-II Local Routing**

General Purpose Routing

Most Spartan-II FPGA signals are routed on the general purpose routing, and consequently, the majority of interconnect resources are associated with this level of the routing hierarchy. The general routing resources are located in horizontal and vertical routing channels associated with the rows and columns CLBs. The general-purpose routing resources are listed below.

- Adjacent to each CLB is a General Routing Matrix (GRM). The GRM is the switch matrix through which horizontal and vertical routing resources connect, and is also the means by which the CLB gains access to the general purpose routing.

- 24 single-length lines route GRM signals to adjacent GRMs in each of the four directions.

- 96 buffered Hex lines route GRM signals to other GRMs six blocks away in each one of the four directions. Organized in a staggered pattern, Hex lines may be driven only at their endpoints. Hex-line signals can be accessed either at the endpoints or at the midpoint (three blocks from the source). One third of the Hex lines are bidirectional, while the remaining ones are unidirectional.

- 12 Longlines are buffered, bidirectional wires that distribute signals across the device quickly and

efficiently. Vertical Longlines span the full height of the device, and horizontal ones span the full width of the device.

I/O Routing

Spartan-II devices have additional routing resources around their periphery that form an interface between the CLB array and the IOBs. This additional routing, called the VersaRing, facilitates pin-swapping and pin-locking, such that logic redesigns can adapt to existing PCB layouts. Time-to-market is reduced, since PCBs and other system components can be manufactured while the logic design is still in progress.

Dedicated Routing

Some classes of signal require dedicated routing resources to maximize performance. In the Spartan-II architecture, dedicated routing resources are provided for two classes of signal.

- Horizontal routing resources are provided for on-chip 3-state busses. Four partitionable bus lines are provided per CLB row, permitting multiple busses within a row, as shown in Figure 7.

- Two dedicated nets per CLB propagate carry signals vertically to the adjacent CLB.

Global Routing

Global Routing resources distribute clocks and other signals with very high fanout throughout the device. Spartan-II devices include two tiers of global routing resources referred to as primary and secondary global routing resources.

- The primary global routing resources are four dedicated global nets with dedicated input pins that are designed to distribute high-fanout clock signals with minimal skew. Each global clock net can drive all CLB, IOB, and block RAM clock pins. The primary global nets may only be driven by global buffers. There are four global buffers, one for each global net.

- The secondary global routing resources consist of 24 backbone lines, 12 across the top of the chip and 12 across bottom. From these lines, up to 12 unique signals per column can be distributed via the 12 longlines in the column. These secondary resources are more flexible than the primary resources since they are not restricted to routing only to clock pins.

Master Serial Mode

In Master Serial mode, the CCLK output of the FPGA drives a Xilinx PROM which feeds a serial stream of configuration data to the FPGA's DIN input. Figure 15 shows a Master Serial FPGA configuring a Slave Serial FPGA from a PROM. A Spartan-II device in Master Serial mode should be connected as shown for the device on the left side. Master Serial mode is selected by a <00x> on the mode pins (M0, M1, M2). The PROM RESET pin is driven by $\overline{INIT}$, and CE input is driven by DONE. The interface is identical to the slave serial mode except that an oscillator internal to the FPGA is used to generate the configuration clock (CCLK). Any of a number of different frequencies ranging from 4 to 60 MHz can be set using the ConfigRate option in the Xilinx software. On power-up, while the first 60 bytes of the configuration data are being loaded, the CCLK frequency is always 2.5 MHz. This frequency is used until the ConfigRate bits, part of the configuration file, have been loaded into the FPGA, at which point, the frequency changes to the selected ConfigRate. Unless a different frequency is specified in the design, the default ConfigRate is 4 MHz. The frequency of the CCLK signal created by the internal oscillator has a variance of +45%, –30% from the specified value.

Figure 17 shows the timing for Master Serial configuration. The FPGA accepts one bit of configuration data on each rising CCLK edge. After the FPGA has been loaded, the data for the next device in a daisy-chain is presented on the DOUT pin after the rising CCLK edge.
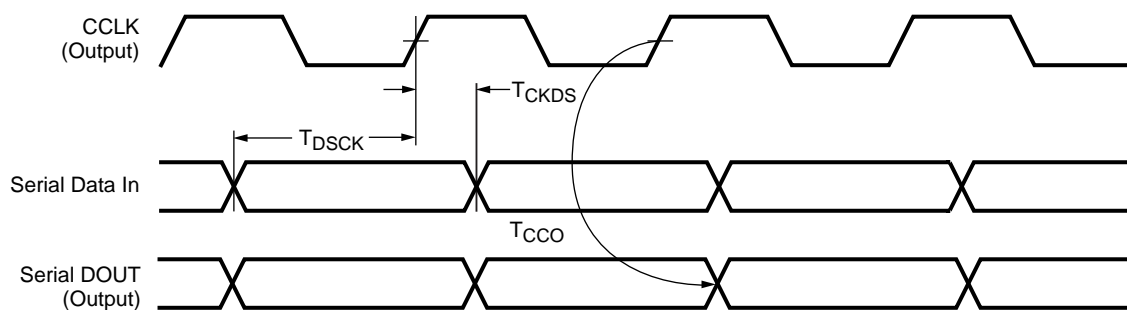
DS001_17_110101

Symbol		Description		Units
T_{DSCK}	CCLK	DIN setup	5.0	ns, min
T_{CKDS}		DIN hold	0.0	ns, min
		Frequency tolerance with respect to nominal	+45%, −30%	-

Figure 17: **Master Serial Mode Timing**

Slave Parallel Mode

The Slave Parallel mode is the fastest configuration option. Byte-wide data is written into the FPGA. A BUSY flag is provided for controlling the flow of data at a clock frequency F_{CCNH} above 50 MHz.

Figure 18, page 24 shows the connections for two Spartan-II devices using the Slave Parallel mode. Slave Parallel mode is selected by a <011> on the mode pins (M0, M1, M2).

If a configuration file of the format .bit, .rbt, or non-swapped HEX is used for parallel programming, then the most significant bit (i.e. the left-most bit of each configuration byte, as displayed in a text editor) must be routed to the D0 input on the FPGA.

The agent controlling configuration is not shown. Typically, a processor, a microcontroller, or CPLD controls the Slave Parallel interface. The controlling agent provides byte-wide configuration data, CCLK, a Chip Select ($\overline{CS}$) signal and a Write signal ($\overline{WRITE}$). If BUSY is asserted (High) by the FPGA, the data must be held until BUSY goes Low.

After configuration, the pins of the Slave Parallel port (D0-D7) can be used as additional user I/O. Alternatively, the port may be retained to permit high-speed 8-bit readback. Then data can be read by de-asserting $\overline{WRITE}$. See "Readback," page 25.

BUFGDLL Pin Descriptions

Use the BUFGDLL macro as the simplest way to provide zero propagation delay for a high-fanout on-chip clock from an external input. This macro uses the IBUFG, CLKDLL and BUFG primitives to implement the most basic DLL application as shown in Figure 25.
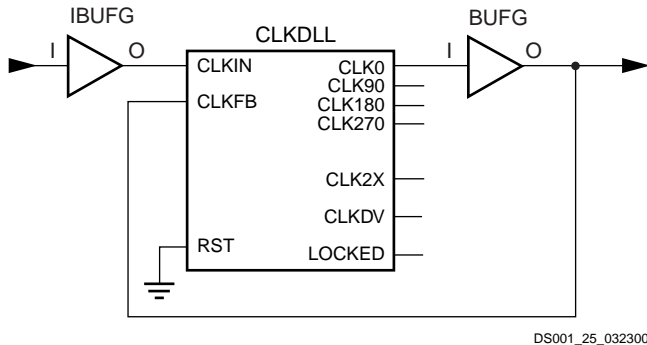

DS001_25_032300

Figure 25: **BUFGDLL Block Diagram**

This macro does not provide access to the advanced clock domain controls or to the clock multiplication or clock division features of the DLL. This macro also does not provide access to the RST or LOCKED pins of the DLL. For access to these features, a designer must use the DLL primitives described in the following sections.

Source Clock Input — I

The I pin provides the user source clock, the clock signal on which the DLL operates, to the BUFGDLL. For the BUFGDLL macro the source clock frequency must fall in the low frequency range as specified in the data sheet. The BUFGDLL requires an external signal source clock. Therefore, only an external input port can source the signal that drives the BUFGDLL I pin.

Clock Output — O

The clock output pin O represents a delay-compensated version of the source clock (I) signal. This signal, sourced by a global clock buffer BUFG primitive, takes advantage of the dedicated global clock routing resources of the device.

The output clock has a 50/50 duty cycle unless you deactivate the duty cycle correction property.

CLKDLL Primitive Pin Descriptions

The library CLKDLL primitives provide access to the complete set of DLL features needed when implementing more complex applications with the DLL.

Source Clock Input — CLKIN

The CLKIN pin provides the user source clock (the clock signal on which the DLL operates) to the DLL. The CLKIN frequency must fall in the ranges specified in the data sheet. A global clock buffer (BUFG) driven from another CLKDLL

or one of the global clock input buffers (IBUFG) on the same edge of the device (top or bottom) must source this clock signal.

Feedback Clock Input — CLKFB

The DLL requires a reference or feedback signal to provide the delay-compensated output. Connect only the CLK0 or CLK2X DLL outputs to the feedback clock input (CLKFB) pin to provide the necessary feedback to the DLL. Either a global clock buffer (BUFG) or one of the global clock input buffers (IBUFG) on the same edge of the device (top or bottom) must source this clock signal.

If an IBUFG sources the CLKFB pin, the following special rules apply.

1. An external input port must source the signal that drives the IBUFG I pin.

2. The CLK2X output must feed back to the device if both the CLK0 and CLK2X outputs are driving off chip devices.

3. That signal must directly drive only OBUFs and nothing else.

These rules enable the software to determine which DLL clock output sources the CLKFB pin.

Reset Input — RST

When the reset pin RST activates, the LOCKED signal deactivates within four source clock cycles. The RST pin, active High, must either connect to a dynamic signal or be tied to ground. As the DLL delay taps reset to zero, glitches can occur on the DLL clock output pins. Activation of the RST pin can also severely affect the duty cycle of the clock output pins. Furthermore, the DLL output clocks no longer deskew with respect to one another. The DLL must be reset when the input clock frequency changes, if the device is reconfigured in Boundary-Scan mode, if the device undergoes a hot swap, and after the device is configured if the input clock is not stable during the startup sequence.

2x Clock Output — CLK2X

The output pin CLK2X provides a frequency-doubled clock with an automatic 50/50 duty-cycle correction. Until the CLKDLL has achieved lock, the CLK2X output appears as a 1x version of the input clock with a 25/75 duty cycle. This behavior allows the DLL to lock on the correct edge with respect to source clock. This pin is not available on the CLKDLLHF primitive.

Clock Divide Output — CLKDV

The clock divide output pin CLKDV provides a lower frequency version of the source clock. The CLKDV_DIVIDE property controls CLKDV such that the source clock is divided by N where N is either 1.5, 2, 2.5, 3, 4, 5, 8, or 16.

This feature provides automatic duty cycle correction. The CLKDV output pin has a 50/50 duty cycle for all values of the

Table 11: **Available Library Primitives**

Primitive	Port A Width	Port B Width
RAMB4_S4 RAMB4_S4_S4 RAMB4_S4_S8 RAMB4_S4_S16	4	N/A 4 8 16
RAMB4_S8 RAMB4_S8_S8 RAMB4_S8_S16	8	N/A 8 16
RAMB4_S16 RAMB4_S16_S16	16	N/A 16

Port Signals

Each block RAM port operates independently of the others while accessing the same set of 4096 memory cells.

Table 12 describes the depth and width aspect ratios for the block RAM memory.

Table 12: **Block RAM Port Aspect Ratios**

Width	Depth	ADDR Bus	Data Bus
1	4096	ADDR<11:0>	DATA<0>
2	2048	ADDR<10:0>	DATA<1:0>
4	1024	ADDR<9:0>	DATA<3:0>
8	512	ADDR<8:0>	DATA<7:0>
16	256	ADDR<7:0>	DATA<15:0>

Clock—CLK[A|B]

Each port is fully synchronous with independent clock pins. All port input pins have setup time referenced to the port CLK pin. The data output bus has a clock-to-out time referenced to the CLK pin.

Enable—EN[A|B]

The enable pin affects the read, write and reset functionality of the port. Ports with an inactive enable pin keep the output pins in the previous state and do not write data to the memory cells.

Write Enable—WE[A|B]

Activating the write enable pin allows the port to write to the memory cells. When active, the contents of the data input bus are written to the RAM at the address pointed to by the address bus, and the new data also reflects on the data out bus. When inactive, a read operation occurs and the contents of the memory cells referenced by the address bus reflect on the data out bus.

Reset—RST[A|B]

The reset pin forces the data output bus latches to zero synchronously. This does not affect the memory cells of the RAM and does not disturb a write operation on the other port.

Address Bus—ADDR[A|B]<#:0>

The address bus selects the memory cells for read or write. The width of the port determines the required width of this bus as shown in Table 12.

Data In Bus—DI[A|B]<#:0>

The data in bus provides the new data value to be written into the RAM. This bus and the port have the same width, as shown in Table 12.

Data Output Bus—DO[A|B]<#:0>

The data out bus reflects the contents of the memory cells referenced by the address bus at the last active clock edge. During a write operation, the data out bus reflects the data in bus. The width of this bus equals the width of the port. The allowed widths appear in Table 12.

Inverting Control Pins

The four control pins (CLK, EN, WE and RST) for each port have independent inversion control as a configuration option.

Address Mapping

Each port accesses the same set of 4096 memory cells using an addressing scheme dependent on the width of the port. The physical RAM location addressed for a particular width are described in the following formula (of interest only when the two ports use different aspect ratios).

$$Start = ([ADDR_{port} + 1] * Width_{port}) - 1$$

$$End = ADDR_{port} * Width_{port}$$

Table 13 shows low order address mapping for each port width.

Table 13: **Port Address Mapping**

Port Width	Port Addresses																
1	4095...	15	14	13	12	11	10	09	08	07	06	05	04	03	02	01	00
2	2047...	07		06		05		04		03		02		01		00	
4	1023...	03				02				01				00			
8	511...	01								00							
16	255...	00															

the LOC property is described below. Table 16 summarizes the input standards compatibility requirements.

An optional delay element is associated with each IBUF. When the IBUF drives a flip-flop within the IOB, the delay element by default activates to ensure a zero hold-time requirement. The NODELAY=TRUE property overrides this default.

When the IBUF does not drive a flip-flop within the IOB, the delay element de-activates by default to provide higher performance. To delay the input signal, activate the delay element with the DELAY=TRUE property.

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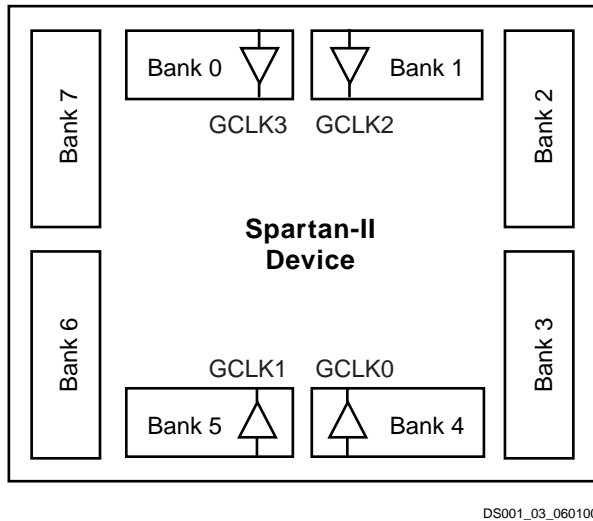
Figure 36: **I/O Banks**

Table 16: **Xilinx Input Standards Compatibility Requirements**

Rule 1	All differential amplifier input signals within a bank are required to be of the same standard.
Rule 2	There are no placement restrictions for inputs with standards that require a single-ended input buffer.

IBUFG

Signals used as high fanout clock inputs to the Spartan-II device should drive a global clock input buffer (IBUFG) via an external input port in order to take advantage of one of the four dedicated global clock distribution networks. The output of the IBUFG primitive can only drive a CLKDLL, CLKDLLHF, or a BUFG primitive. The generic IBUFG primitive appears in Figure 37.

DS001_37_061200
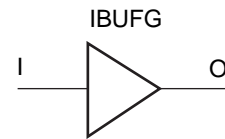
Figure 37: **Global Clock Input Buffer (IBUFG) Primitive**

With no extension or property specified for the generic IBUFG primitive, the assumed standard is LVTTL.

The voltage reference signal is "banked" within the Spartan-II device on a half-edge basis such that for all packages there are eight independent V_{REF} banks internally. See Figure 36 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a V_{REF} input.

IBUFG placement restrictions require any differential amplifier input signals within a bank be of the same standard. The LOC property can specify a location for the IBUFG.

As an added convenience, the BUFGP can be used to instantiate a high fanout clock input. The BUFGP primitive represents a combination of the LVTTL IBUFG and BUFG primitives, such that the output of the BUFGP can connect directly to the clock pins throughout the design.

The Spartan-II FPGA BUFGP primitive can only be placed in a global clock pad location. The LOC property can specify a location for the BUFGP.

OBUF

An OBUF must drive outputs through an external output port. The generic output buffer (OBUF) primitive appears in Figure 38.

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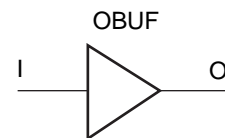
Figure 38: **Output Buffer (OBUF) Primitive**

With no extension or property specified for the generic OBUF primitive, the assumed standard is slew rate limited LVTTL with 12 mA drive strength.

The LVTTL OBUF additionally can support one of two slew rate modes to minimize bus transients. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals.

LVTTL

LVTTL requires no termination. DC voltage specifications appears in Table 32 for the LVTTL standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

Table 32: **LVTTL Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	3.0	3.3	3.6
V_{REF}	-	-	-
V_{TT}	-	-	-
V_{IH}	2.0	-	5.5
V_{IL}	–0.5	-	0.8
V_{OH}	2.4	-	-
V_{OL}	-	-	0.4
I_{OH} at V_{OH} (mA)	–24	-	-
I_{OL} at V_{OL} (mA)	24	-	-

Notes:
1. V_{OL} and V_{OH} for lower drive currents sample tested.

LVCMOS2

LVCMOS2 requires no termination. DC voltage specifications appear in Table 33 for the LVCMOS2 standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

Table 33: **LVCMOS2 Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	2.3	2.5	2.7
V_{REF}	-	-	-
V_{TT}	-	-	-
V_{IH}	1.7	-	5.5
V_{IL}	–0.5	-	0.7
V_{OH}	1.9	-	-
V_{OL}	-	-	0.4
I_{OH} at V_{OH} (mA)	–12	-	-
I_{OL} at V_{OL} (mA)	12	-	-

AGP-2X

The specification for the AGP-2X standard does not document a recommended termination technique. DC voltage specifications appear in Table 34 for the AGP-2X standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

Table 34: **AGP-2X Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	3.0	3.3	3.6
$V_{REF} = N \times V_{CCO}$[1]	1.17	1.32	1.48
V_{TT}	-	-	-
$V_{IH} \geq V_{REF} + 0.2$	1.37	1.52	-
$V_{IL} \leq V_{REF} - 0.2$	-	1.12	1.28
$V_{OH} \geq 0.9 \times V_{CCO}$	2.7	3.0	-
$V_{OL} \leq 0.1 \times V_{CCO}$	-	0.33	0.36
I_{OH} at V_{OH} (mA)	Note 2	-	-
I_{OL} at V_{OL} (mA)	Note 2	-	-

Notes:
1. N must be greater than or equal to 0.39 and less than or equal to 0.41.
2. Tested according to the relevant specification.

For design examples and more information on using the I/O, see XAPP179, *Using SelectIO Interfaces in Spartan-II and Spartan-IIE FPGAs.*

Recommended Operating Conditions

Symbol	Description		Min	Max	Units
T_J	Junction temperature[1]	Commercial	0	85	°C
		Industrial	−40	100	°C
V_{CCINT}	Supply voltage relative to GND[2,5]	Commercial	2.5 − 5%	2.5 + 5%	V
		Industrial	2.5 − 5%	2.5 + 5%	V
V_{CCO}	Supply voltage relative to GND[3,5]	Commercial	1.4	3.6	V
		Industrial	1.4	3.6	V
T_{IN}	Input signal transition time[4]		-	250	ns

Notes:

1. At junction temperatures above those listed as Operating Conditions, all delay parameters increase by 0.35% per °C.
2. Functional operation is guaranteed down to a minimum V_{CCINT} of 2.25V (Nominal V_{CCINT} − 10%). For every 50 mV reduction in V_{CCINT} below 2.375V (nominal V_{CCINT} − 5%), all delay parameters increase by 3%.
3. Minimum and maximum values for V_{CCO} vary according to the I/O standard selected.
4. Input and output measurement threshold is ~50% of V_{CCO}. See "Delay Measurement Methodology," page 60 for specific levels.
5. Supply voltages may be applied in any order desired.

DC Characteristics Over Operating Conditions

Symbol	Description			Min	Typ	Max	Units
V_{DRINT}	Data Retention V_{CCINT} voltage (below which configuration data may be lost)			2.0	-	-	V
V_{DRIO}	Data Retention V_{CCO} voltage (below which configuration data may be lost)			1.2	-	-	V
I_{CCINTQ}	Quiescent V_{CCINT} supply current[1]	XC2S15	Commercial	-	10	30	mA
			Industrial	-	10	60	mA
		XC2S30	Commercial	-	10	30	mA
			Industrial	-	10	60	mA
		XC2S50	Commercial	-	12	50	mA
			Industrial	-	12	100	mA
		XC2S100	Commercial	-	12	50	mA
			Industrial	-	12	100	mA
		XC2S150	Commercial	-	15	50	mA
			Industrial	-	15	100	mA
		XC2S200	Commercial	-	15	75	mA
			Industrial	-	15	150	mA
I_{CCOQ}	Quiescent V_{CCO} supply current[1]			-	-	2	mA
I_{REF}	V_{REF} current per V_{REF} pin			-	-	20	μA
I_L	Input or output leakage current[2]			−10	-	+10	μA
C_{IN}	Input capacitance (sample tested)	VQ, CS, TQ, PQ, FG packages		-	-	8	pF
I_{RPU}	Pad pull-up (when selected) @ V_{IN} = 0V, V_{CCO} = 3.3V (sample tested)[3]			-	-	0.25	mA
I_{RPD}	Pad pull-down (when selected) @ V_{IN} = 3.6V (sample tested)[3]			-	-	0.15	mA

Notes:

1. With no output current loads, no active input pull-up resistors, all I/O pins 3-stated and floating.
2. The I/O leakage current specification applies only when the V_{CCINT} and V_{CCO} supply voltages have reached their respective minimum Recommended Operating Conditions.
3. Internal pull-up and pull-down resistors guarantee valid logic levels at unconnected input pins. These pull-up and pull-down resistors do not provide valid logic levels when input pins are connected to other circuits.

IOB Input Delay Adjustments for Different Standards[1]

Input delays associated with the pad are specified for LVTTL. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

Symbol	Description	Standard	Speed Grade		Units
			-6	**-5**	
Data Input Delay Adjustments					
T_{ILVTTL}	Standard-specific data input delay adjustments	LVTTL	0	0	ns
$T_{ILVCMOS2}$		LVCMOS2	−0.04	−0.05	ns
T_{IPCI33_3}		PCI, 33 MHz, 3.3V	−0.11	−0.13	ns
T_{IPCI33_5}		PCI, 33 MHz, 5.0V	0.26	0.30	ns
T_{IPCI66_3}		PCI, 66 MHz, 3.3V	−0.11	−0.13	ns
T_{IGTL}		GTL	0.20	0.24	ns
T_{IGTLP}		GTL+	0.11	0.13	ns
T_{IHSTL}		HSTL	0.03	0.04	ns
T_{ISSTL2}		SSTL2	−0.08	−0.09	ns
T_{ISSTL3}		SSTL3	−0.04	−0.05	ns
T_{ICTT}		CTT	0.02	0.02	ns
T_{IAGP}		AGP	−0.06	−0.07	ns

Notes:
1. Input timing for LVTTL is measured at 1.4V. For other I/O standards, see the table "Delay Measurement Methodology," page 60.

IOB Output Delay Adjustments for Different Standards[1]

Output delays terminating at a pad are specified for LVTTL with 12 mA drive and fast slew rate. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

			Speed Grade		
Symbol	Description	Standard	-6	-5	Units
Output Delay Adjustments (Adj)					
T_{OLVTTL_S2}	Standard-specific adjustments for output delays terminating at pads (based on standard capacitive load, C_{SL})	LVTTL, Slow, 2 mA	14.2	16.9	ns
T_{OLVTTL_S4}		4 mA	7.2	8.6	ns
T_{OLVTTL_S6}		6 mA	4.7	5.5	ns
T_{OLVTTL_S8}		8 mA	2.9	3.5	ns
T_{OLVTTL_S12}		12 mA	1.9	2.2	ns
T_{OLVTTL_S16}		16 mA	1.7	2.0	ns
T_{OLVTTL_S24}		24 mA	1.3	1.5	ns
T_{OLVTTL_F2}		LVTTL, Fast, 2 mA	12.6	15.0	ns
T_{OLVTTL_F4}		4 mA	5.1	6.1	ns
T_{OLVTTL_F6}		6 mA	3.0	3.6	ns
T_{OLVTTL_F8}		8 mA	1.0	1.2	ns
T_{OLVTTL_F12}		12 mA	0	0	ns
T_{OLVTTL_F16}		16 mA	−0.1	−0.1	ns
T_{OLVTTL_F24}		24 mA	−0.1	−0.2	ns
$T_{OLVCMOS2}$		LVCMOS2	0.2	0.2	ns
T_{OPCI33_3}		PCI, 33 MHz, 3.3V	2.4	2.9	ns
T_{OPCI33_5}		PCI, 33 MHz, 5.0V	2.9	3.5	ns
T_{OPCI66_3}		PCI, 66 MHz, 3.3V	−0.3	−0.4	ns
T_{OGTL}		GTL	0.6	0.7	ns
T_{OGTLP}		GTL+	0.9	1.1	ns
T_{OHSTL_I}		HSTL I	−0.4	−0.5	ns
T_{OHSTL_III}		HSTL III	−0.8	−1.0	ns
T_{OHSTL_IV}		HSTL IV	−0.9	−1.1	ns
T_{OSSTL2_I}		SSTL2 I	−0.4	−0.5	ns
T_{OSSLT2_II}		SSTL2 II	−0.8	−1.0	ns
T_{OSSTL3_I}		SSTL3 I	−0.4	−0.5	ns
T_{OSSTL3_II}		SSTL3 II	−0.9	−1.1	ns
T_{OCTT}		CTT	−0.5	−0.6	ns
T_{OAGP}		AGP	−0.8	−1.0	ns

Notes:
1. Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. For other I/O standards and different loads, see the tables "Constants for Calculating TIOOP" and "Delay Measurement Methodology," page 60.

DLL Timing Parameters

All devices are 100 percent functionally tested. Because of the difficulty in directly measuring many internal timing parameters, those parameters are derived from benchmark timing patterns. The following guidelines reflect worst-case values across the recommended operating conditions.

Symbol	Description	Speed Grade				Units
		-6		-5		
		Min	Max	Min	Max	
$F_{CLKINHF}$	Input clock frequency (CLKDLLHF)	60	200	60	180	MHz
$F_{CLKINLF}$	Input clock frequency (CLKDLL)	25	100	25	90	MHz
$T_{DLLPWHF}$	Input clock pulse width (CLKDLLHF)	2.0	-	2.4	-	ns
$T_{DLLPWLF}$	Input clock pulse width (CLKDLL)	2.5	-	3.0	-	ns

DLL Clock Tolerance, Jitter, and Phase Information

All DLL output jitter and phase specifications were determined through statistical measurement at the package pins using a clock mirror configuration and matched drivers. Figure 52, page 63, provides definitions for various parameters in the table below.

Symbol	Description	F_{CLKIN}	CLKDLLHF		CLKDLL		Units
			Min	Max	Min	Max	
T_{IPTOL}	Input clock period tolerance		-	1.0	-	1.0	ns
T_{IJITCC}	Input clock jitter tolerance (cycle-to-cycle)		-	±150	-	±300	ps
T_{LOCK}	Time required for DLL to acquire lock	> 60 MHz	-	20	-	20	µs
		50-60 MHz	-	-	-	25	µs
		40-50 MHz	-	-	-	50	µs
		30-40 MHz	-	-	-	90	µs
		25-30 MHz	-	-	-	120	µs
T_{OJITCC}	Output jitter (cycle-to-cycle) for any DLL clock output[1]		-	±60	-	±60	ps
T_{PHIO}	Phase offset between CLKIN and CLKO[2]		-	±100	-	±100	ps
T_{PHOO}	Phase offset between clock outputs on the DLL[3]		-	±140	-	±140	ps
T_{PHIOM}	Maximum phase difference between CLKIN and CLKO[4]		-	±160	-	±160	ps
T_{PHOOM}	Maximum phase difference between clock outputs on the DLL[5]		-	±200	-	±200	ps

Notes:
1. **Output Jitter** is cycle-to-cycle jitter measured on the DLL output clock, *excluding* input clock jitter.
2. **Phase Offset between CLKIN and CLKO** is the worst-case fixed time difference between rising edges of CLKIN and CLKO, *excluding* output jitter and input clock jitter.
3. **Phase Offset between Clock Outputs on the DLL** is the worst-case fixed time difference between rising edges of any two DLL outputs, *excluding* Output Jitter and input clock jitter.
4. **Maximum Phase Difference between CLKIN an CLKO** is the sum of Output Jitter and Phase Offset between CLKIN and CLKO, or the greatest difference between CLKIN and CLKO rising edges due to DLL alone (*excluding* input clock jitter).
5. **Maximum Phase Difference between Clock Outputs on the DLL** is the sum of Output JItter and Phase Offset between any DLL clock outputs, or the greatest difference between any two DLL output rising edges due to DLL alone (*excluding* input clock jitter).

XC2S100 Device Pinouts *(Continued)*

Function	Bank	TQ144	PQ208	FG256	FG456	Bndry Scan
V_{CCINT}	-	-	P38	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	6	-	P39	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
GND	-	P119	P40	GND*	GND*	-
I/O	6	P118	P41	K4	T1	314
I/O, V_{REF}	6	P117	P42	M1	R4	317
I/O	6	-	-	-	T2	320
I/O	6	P116	P43	L4	U1	323
I/O	6	-	-	M2	R5	326
I/O	6	-	P44	L3	U2	332
I/O, V_{REF}	6	P115	P45	N1	T3	335
V_{CCO}	6	-	-	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
GND	-	-	-	GND*	GND*	-
I/O	6	-	P46	P1	T4	338
I/O	6	-	-	L5	W1	341
I/O	6	-	-	-	U4	344
I/O	6	P114	P47	N2	Y1	347
I/O	6	-	-	M4	W2	350
I/O	6	P113	P48	R1	Y2	356
I/O	6	P112	P49	M3	W3	359
M1	-	P111	P50	P2	U5	362
GND	-	P110	P51	GND*	GND*	-
M0	-	P109	P52	N3	AB2	363
V_{CCO}	6	P108	P53	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
V_{CCO}	5	P107	P53	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
M2	-	P106	P54	R3	Y4	364
I/O	5	-	-	N5	V7	374
I/O	5	P103	P57	T2	Y6	377
I/O	5	-	-	-	AA4	380
I/O	5	-	-	P5	W6	383
I/O	5	-	P58	T3	Y7	386
GND	-	-	-	GND*	GND*	-
V_{CCO}	5	-	-	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
I/O, V_{REF}	5	P102	P59	T4	AA5	389
I/O	5	-	P60	M6	AB5	392
I/O	5	-	-	T5	AB6	398
I/O	5	P101	P61	N6	AA7	401
I/O	5	-	-	-	W7	404

XC2S100 Device Pinouts *(Continued)*

Function	Bank	TQ144	PQ208	FG256	FG456	Bndry Scan
I/O, V_{REF}	5	P100	P62	R5	W8	407
I/O	5	P99	P63	P6	Y8	410
GND	-	P98	P64	GND*	GND*	-
V_{CCO}	5	-	P65	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
V_{CCINT}	-	P97	P66	V_{CCINT}*	V_{CCINT}*	-
I/O	5	P96	P67	R6	AA8	413
I/O	5	P95	P68	M7	V9	416
I/O	5	-	-	-	AB9	419
I/O	5	-	P69	N7	Y9	422
I/O	5	-	P70	T6	W10	428
I/O	5	-	P71	P7	AB10	431
GND	-	-	P72	GND*	GND*	-
I/O, V_{REF}	5	P94	P73	P8	Y10	434
I/O	5	-	P74	R7	V11	437
I/O	5	-	-	T7	W11	440
I/O	5	P93	P75	T8	AB11	443
V_{CCINT}	-	P92	P76	V_{CCINT}*	V_{CCINT}*	-
I, GCK1	5	P91	P77	R8	Y11	455
V_{CCO}	5	P90	P78	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
V_{CCO}	4	P90	P78	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P89	P79	GND*	GND*	-
I, GCK0	4	P88	P80	N8	W12	456
I/O	4	P87	P81	N9	U12	460
I/O	4	P86	P82	R9	Y12	466
I/O	4	-	-	N10	AA12	469
I/O	4	-	P83	T9	AB13	472
I/O, V_{REF}	4	P85	P84	P9	AA13	475
GND	-	-	P85	GND*	GND*	-
I/O	4	-	P86	M10	Y13	478
I/O	4	-	P87	R10	V13	481
I/O	4	-	P88	P10	AA14	487
I/O	4	-	-	-	V14	490
I/O	4	P84	P89	T10	AB15	493
I/O	4	P83	P90	R11	AA15	496
V_{CCINT}	-	P82	P91	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	4	-	P92	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P81	P93	GND*	GND*	-
I/O	4	P80	P94	M11	Y15	499

XC2S100 Device Pinouts *(Continued)*

Function	Bank	TQ144	PQ208	FG256	FG456	Bndry Scan
I/O, V_{REF}	4	P79	P95	T11	AB16	502
I/O	4	-	-	-	AB17	505
I/O	4	P78	P96	N11	V15	508
I/O	4	-	-	R12	Y16	511
I/O	4	-	P97	P11	AB18	517
I/O, V_{REF}	4	P77	P98	T12	AB19	520
V_{CCO}	4	-	-	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	-	-	GND*	GND*	-
I/O	4	-	P99	T13	Y17	523
I/O	4	-	-	N12	V16	526
I/O	4	-	-	-	W17	529
I/O	4	P76	P100	R13	AB20	532
I/O	4	-	-	P12	AA19	535
I/O	4	P75	P101	P13	AA20	541
I/O	4	P74	P102	T14	W18	544
GND	-	P73	P103	GND*	GND*	-
DONE	3	P72	P104	R14	Y19	547
V_{CCO}	4	P71	P105	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
V_{CCO}	3	P70	P105	V_{CCO} Bank 3*	V_{CCO} Bank 3*	-
$\overline{PROGRAM}$	-	P69	P106	P15	W20	550
I/O ($\overline{INIT}$)	3	P68	P107	N15	V19	551
I/O (D7)	3	P67	P108	N14	Y21	554
I/O	3	-	-	T15	W21	560
I/O	3	P66	P109	M13	U20	563
I/O	3	-	-	-	U19	566
I/O	3	-	-	R16	T18	569
I/O	3	-	P110	M14	W22	572
GND	-	-	-	GND*	GND*	-
V_{CCO}	3	-	-	V_{CCO} Bank 3*	V_{CCO} Bank 3*	-
I/O, V_{REF}	3	P65	P111	L14	U21	575
I/O	3	-	P112	M15	T20	578
I/O	3	-	-	L12	T21	584
I/O	3	P64	P113	P16	R18	587
I/O	3	-	-	-	U22	590
I/O, V_{REF}	3	P63	P114	L13	R19	593
I/O (D6)	3	P62	P115	N16	T22	596
GND	-	P61	P116	GND*	GND*	-
V_{CCO}	3	-	P117	V_{CCO} Bank 3*	V_{CCO} Bank 3*	-
V_{CCINT}	-	-	P118	V_{CCINT}*	V_{CCINT}*	-
I/O (D5)	3	P60	P119	M16	R21	599
I/O	3	P59	P120	K14	P18	602
I/O	3	-	-	L16	P20	605
I/O	3	-	P121	K13	P21	608
I/O	3	-	P122	L15	N18	614
I/O	3	-	P123	K12	N20	617
GND	-	-	P124	GND*	GND*	-
I/O, V_{REF}	3	P58	P125	K16	N21	620
I/O (D4)	3	P57	P126	J16	N22	623
I/O	3	-	-	J14	M19	626
I/O	3	P56	P127	K15	M20	629
V_{CCINT}	-	P55	P128	E5	V_{CCINT}*	-
I/O, TRDY[1]	3	P54	P129	J15	M22	638
V_{CCO}	3	P53	P130	V_{CCO} Bank 3*	V_{CCO} Bank 3*	-
V_{CCO}	2	P53	P130	V_{CCO} Bank 2*	V_{CCO} Bank 2*	-
GND	-	P52	P131	GND*	GND*	-
I/O, IRDY[1]	2	P51	P132	H16	L20	641
I/O	2	-	P133	H14	L17	644
I/O	2	P50	P134	H15	L21	650
I/O	2	-	-	J13	L22	653
I/O (D3)	2	P49	P135	G16	K20	656
I/O, V_{REF}	2	P48	P136	H13	K21	659
GND	-	-	P137	GND*	GND*	-
I/O	2	-	P138	G14	K22	662
I/O	2	-	P139	G15	J21	665
I/O	2	-	P140	G12	J18	671
I/O	2	-	-	F16	J22	674
I/O	2	P47	P141	G13	H19	677
I/O (D2)	2	P46	P142	F15	H20	680
V_{CCINT}	-	-	P143	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	2	-	P144	V_{CCO} Bank 2*	V_{CCO} Bank 2*	-
GND	-	P45	P145	GND*	GND*	-
I/O (D1)	2	P44	P146	E16	H22	683
I/O, V_{REF}	2	P43	P147	F14	H18	686
I/O	2	-	-	-	G21	689
I/O	2	P42	P148	D16	G18	692

XC2S100 Device Pinouts *(Continued)*

XC2S100 Pad Name Function	Bank	TQ144	PQ208	FG256	FG456	Bndry Scan
I/O	2	-	-	F12	G20	695
I/O	2	-	P149	E15	F19	701
I/O, V$_{REF}$	2	P41	P150	F13	F21	704
V$_{CCO}$	2	-	-	V$_{CCO}$ Bank 2*	V$_{CCO}$ Bank 2*	-
GND	-	-	-	GND*	GND*	-
I/O	2	-	P151	E14	F20	707
I/O	2	-	-	C16	F18	710
I/O	2	-	-	-	E21	713
I/O	2	P40	P152	E13	D22	716
I/O	2	-	-	B16	E20	719
I/O (DIN, D0)	2	P39	P153	D14	D20	725
I/O (DOUT, BUSY)	2	P38	P154	C15	C21	728
CCLK	2	P37	P155	D15	B22	731
V$_{CCO}$	2	P36	P156	V$_{CCO}$ Bank 2*	V$_{CCO}$ Bank 2*	-
V$_{CCO}$	1	P35	P156	V$_{CCO}$ Bank 1*	V$_{CCO}$ Bank 1*	-
TDO	2	P34	P157	B14	A21	-
GND	-	P33	P158	GND*	GND*	-
TDI	-	P32	P159	A15	B20	-
I/O ($\overline{CS}$)	1	P31	P160	B13	C19	0
I/O ($\overline{WRITE}$)	1	P30	P161	C13	A20	3
I/O	1	-	-	C12	D17	9
I/O	1	P29	P162	A14	A19	12
I/O	1	-	-	-	B18	15
I/O	1	-	-	D12	C17	18
I/O	1	-	P163	B12	D16	21
GND	-	-	-	GND*	GND*	-
V$_{CCO}$	1	-	-	V$_{CCO}$ Bank 1*	V$_{CCO}$ Bank 1*	-
I/O, V$_{REF}$	1	P28	P164	C11	A18	24
I/O	1	-	P165	A13	B17	27
I/O	1	-	-	D11	D15	33
I/O	1	-	P166	A12	C16	36
I/O	1	-	-	-	D14	39
I/O, V$_{REF}$	1	P27	P167	E11	E14	42
I/O	1	P26	P168	B11	A16	45
GND	-	P25	P169	GND*	GND*	-
V$_{CCO}$	1	-	P170	V$_{CCO}$ Bank 1*	V$_{CCO}$ Bank 1*	-
V$_{CCINT}$	-	P24	P171	V$_{CCINT}$*	V$_{CCINT}$*	-
I/O	1	P23	P172	A11	C15	48
I/O	1	P22	P173	C10	B15	51
I/O	1	-	-	-	F12	54
I/O	1	-	P174	B10	C14	57
I/O	1	-	P175	D10	D13	63
I/O	1	-	P176	A10	C13	66
GND	-	-	P177	GND*	GND*	-
I/O, V$_{REF}$	1	P21	P178	B9	B13	69
I/O	1	-	P179	E10	E12	72
I/O	1	-	-	A9	B12	75
I/O	1	P20	P180	D9	D12	78
I/O	1	P19	P181	A8	D11	84
I, GCK2	1	P18	P182	C9	A11	90
GND	-	P17	P183	GND*	GND*	-
V$_{CCO}$	1	P16	P184	V$_{CCO}$ Bank 1*	V$_{CCO}$ Bank 1*	-
V$_{CCO}$	0	P16	P184	V$_{CCO}$ Bank 0*	V$_{CCO}$ Bank 0*	-
I, GCK3	0	P15	P185	B8	C11	91
V$_{CCINT}$	-	P14	P186	V$_{CCINT}$*	V$_{CCINT}$*	-
I/O	0	P13	P187	A7	A10	101
I/O	0	-	-	D8	B10	104

XC2S100 Device Pinouts *(Continued)*

XC2S100 Pad Name						Bndry Scan
Function	Bank	TQ144	PQ208	FG256	FG456	
I/O	0	-	P188	A6	C10	107
I/O, V_{REF}	0	P12	P189	B7	A9	110
GND	-	-	P190	GND*	GND*	-
I/O	0	-	P191	C8	B9	113
I/O	0	-	P192	D7	E10	116
I/O	0	-	P193	E7	A8	122
I/O	0	-	-	-	D9	125
I/O	0	P11	P194	C7	E9	128
I/O	0	P10	P195	B6	A7	131
V_{CCINT}	-	P9	P196	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	0	-	P197	V_{CCO} Bank 0*	V_{CCO} Bank 0*	-
GND	-	P8	P198	GND*	GND*	-
I/O	0	P7	P199	A5	B7	134
I/O, V_{REF}	0	P6	P200	C6	E8	137
I/O	0	-	-	-	D8	140
I/O	0	-	P201	B5	C7	143
I/O	0	-	-	D6	D7	146
I/O	0	-	P202	A4	D6	152
I/O, V_{REF}	0	P5	P203	B4	C6	155
V_{CCO}	0	-	-	V_{CCO} Bank 0*	V_{CCO} Bank 0*	-
GND	-	-	-	GND*	GND*	-
I/O	0	-	P204	E6	B5	158
I/O	0	-	-	D5	E7	161
I/O	0	-	-	-	E6	164
I/O	0	P4	P205	A3	B4	167
I/O	0	-	-	C5	A3	170
I/O	0	P3	P206	B3	C5	176
TCK	-	P2	P207	C4	C4	-
V_{CCO}	0	P1	P208	V_{CCO} Bank 0*	V_{CCO} Bank 0*	-
V_{CCO}	7	P144	P208	V_{CCO} Bank 7*	V_{CCO} Bank 7*	-

04/18/01

Notes:
1. IRDY and TRDY can only be accessed when using Xilinx PCI cores.
2. Pads labelled GND*, V_{CCINT}*, V_{CCO} Bank 0*, V_{CCO} Bank 1*, V_{CCO} Bank 2*, V_{CCO} Bank 3*, V_{CCO} Bank 4*, V_{CCO} Bank 5*, V_{CCO} Bank 6*, V_{CCO} Bank 7* are internally bonded to independent ground or power planes within the package.
3. See "VCCO Banks" for details on V_{CCO} banking.

XC2S150 Device Pinouts

XC2S150 Pad Name					Bndry Scan
Function	Bank	PQ208	FG256	FG456	
GND	-	P1	GND*	GND*	-
TMS	-	P2	D3	D3	-
I/O	7	P3	C2	B1	221
I/O	7	-	-	E4	224
I/O	7	-	-	C1	227
I/O	7	-	A2	F5	230
GND	-	-	GND*	GND*	-
I/O	7	P4	B1	D2	233
I/O	7	-	-	E3	236
I/O	7	-	-	F4	239
I/O	7	-	E3	G5	242
I/O	7	P5	D2	F3	245
GND	-	-	GND*	GND*	-
V$_{CCO}$	7	-	V$_{CCO}$ Bank 7*	V$_{CCO}$ Bank 7*	-
I/O, V$_{REF}$	7	P6	C1	E2	248
I/O	7	P7	F3	E1	251
I/O	7	-	-	G4	254
I/O	7	-	-	G3	257
I/O	7	-	E2	H5	260
I/O	7	P8	E4	F2	263
I/O	7	-	-	F1	266
I/O, V$_{REF}$	7	P9	D1	H4	269
I/O	7	P10	E1	G1	272
GND	-	P11	GND*	GND*	-
V$_{CCO}$	7	P12	V$_{CCO}$ Bank 7*	V$_{CCO}$ Bank 7*	-
V$_{CCINT}$	-	P13	V$_{CCINT}$*	V$_{CCINT}$*	-
I/O	7	P14	F2	H3	275
I/O	7	P15	G3	H2	278
I/O	7	-	-	H1	284
I/O	7	-	F1	J5	287
I/O	7	P16	F4	J2	290
I/O	7	-	-	J3	293
I/O	7	P17	F5	K5	299
I/O	7	P18	G2	K1	302
GND	-	P19	GND*	GND*	-
V$_{CCO}$	7	-	V$_{CCO}$ Bank 7*	V$_{CCO}$ Bank 7*	-
I/O, V$_{REF}$	7	P20	H3	K3	305
I/O	7	P21	G4	K4	308
I/O	7	-	H2	L6	311

XC2S150 Device Pinouts *(Continued)*

XC2S150 Pad Name					Bndry Scan
Function	Bank	PQ208	FG256	FG456	
I/O	7	P22	G5	L1	314
I/O	7	-	-	L5	317
I/O	7	P23	H4	L4	320
I/O, IRDY[1]	7	P24	G1	L3	323
GND	-	P25	GND*	GND*	-
V$_{CCO}$	7	P26	V$_{CCO}$ Bank 7*	V$_{CCO}$ Bank 7*	-
V$_{CCO}$	6	P26	V$_{CCO}$ Bank 6*	V$_{CCO}$ Bank 6*	-
I/O, TRDY[1]	6	P27	J2	M1	326
V$_{CCINT}$	-	P28	V$_{CCINT}$*	V$_{CCINT}$*	-
I/O	6	-	-	M6	332
I/O	6	P29	H1	M3	335
I/O	6	-	J4	M4	338
I/O	6	P30	J1	M5	341
I/O, V$_{REF}$	6	P31	J3	N2	344
V$_{CCO}$	6	-	V$_{CCO}$ Bank 6*	V$_{CCO}$ Bank 6*	-
GND	-	P32	GND*	GND*	-
I/O	6	P33	K5	N3	347
I/O	6	P34	K2	N4	350
I/O	6	-	-	N5	356
I/O	6	P35	K1	P2	359
I/O	6	-	K3	P4	362
I/O	6	-	-	R1	365
I/O	6	P36	L1	P3	371
I/O	6	P37	L2	R2	374
V$_{CCINT}$	-	P38	V$_{CCINT}$*	V$_{CCINT}$*	-
V$_{CCO}$	6	P39	V$_{CCO}$ Bank 6*	V$_{CCO}$ Bank 6*	-
GND	-	P40	GND*	GND*	-
I/O	6	P41	K4	T1	377
I/O, V$_{REF}$	6	P42	M1	R4	380
I/O	6	-	-	T2	383
I/O	6	P43	L4	U1	386
I/O	6	-	M2	R5	389
I/O	6	-	-	V1	392
I/O	6	-	-	T5	395
I/O	6	P44	L3	U2	398
I/O, V$_{REF}$	6	P45	N1	T3	401
V$_{CCO}$	6	-	V$_{CCO}$ Bank 6*	V$_{CCO}$ Bank 6*	-
GND	-	-	GND*	GND*	-

Additional XC2S150 Package Pins

PQ208

Not Connected Pins					
P55	P56	-	-	-	-

11/02/00

FG256

V_{CCINT} Pins					
C3	C14	D4	D13	E5	E12
M5	M12	N4	N13	P3	P14
V_{CCO} Bank 0 Pins					
E8	F8	-	-	-	-
V_{CCO} Bank 1 Pins					
E9	F9	-	-	-	-
V_{CCO} Bank 2 Pins					
H11	H12	-	-	-	-
V_{CCO} Bank 3 Pins					
J11	J12	-	-	-	-
V_{CCO} Bank 4 Pins					
L9	M9	-	-	-	-
V_{CCO} Bank 5 Pins					
L8	M8	-	-	-	-
V_{CCO} Bank 6 Pins					
J5	J6	-	-	-	-
V_{CCO} Bank 7 Pins					
H5	H6	-	-	-	-
GND Pins					
A1	A16	B2	B15	F6	F7
F10	F11	G6	G7	G8	G9
G10	G11	H7	H8	H9	H10
J7	J8	J9	J10	K6	K7
K8	K9	K10	K11	L6	L7
L10	L11	R2	R15	T1	T16
Not Connected Pins					
P4	R4	-	-	-	-

11/02/00

Additional XC2S150 Package Pins *(Continued)*

FG456

V_{CCINT} Pins					
E5	E18	F6	F17	G7	G8
G9	G14	G15	G16	H7	H16
J7	J16	P7	P16	R7	R16
T7	T8	T9	T14	T15	T16
U6	U17	V5	V18	-	-
V_{CCO} Bank 0 Pins					
F7	F8	F9	F10	G10	G11
V_{CCO} Bank 1 Pins					
F13	F14	F15	F16	G12	G13
V_{CCO} Bank 2 Pins					
G17	H17	J17	K16	K17	L16
V_{CCO} Bank 3 Pins					
M16	N16	N17	P17	R17	T17
V_{CCO} Bank 4 Pins					
T12	T13	U13	U14	U15	U16
V_{CCO} Bank 5 Pins					
T10	T11	U7	U8	U9	U10
V_{CCO} Bank 6 Pins					
M7	N6	N7	P6	R6	T6
V_{CCO} Bank 7 Pins					
G6	H6	J6	K6	K7	L7
GND Pins					
A1	A22	B2	B21	C3	C20
J9	J10	J11	J12	J13	J14
K9	K10	K11	K12	K13	K14
L9	L10	L11	L12	L13	L14
M9	M10	M11	M12	M13	M14
N9	N10	N11	N12	N13	N14
P9	P10	P11	P12	P13	P14
Y3	Y20	AA2	AA21	AB1	AB22
Not Connected Pins					
A2	A6	A12	A13	A14	B11
B16	C2	C8	C9	D1	D4
D18	D19	E13	E17	E19	F11
G2	G22	H21	J1	J4	K2
K18	K19	L2	L19	M2	M17
M21	N1	P1	P5	P22	R3
R20	R22	U3	U18	V6	W4
W13	W15	W19	Y5	Y22	AA1
AA3	AA9	AA10	AA11	AA16	AB7
AB8	AB12	AB14	AB21	-	-

11/02/00

Product Specification

XC2S200 Device Pinouts *(Continued)*

Function	Bank	PQ208	FG256	FG456	Bndry Scan
I/O	6	-	-	T2	449
I/O	6	P43	L4	U1	452
GND	-	-	GND*	GND*	-
I/O	6	-	M2	R5	455
I/O	6	-	-	V1	458
I/O	6	-	-	T5	461
I/O	6	P44	L3	U2	464
I/O, V$_{REF}$	6	P45	N1	T3	467
V$_{CCO}$	6	-	V$_{CCO}$ Bank 6*	V$_{CCO}$ Bank 6*	-
GND	-	-	GND*	GND*	-
I/O	6	P46	P1	T4	470
I/O	6	-	L5	W1	473
GND	-	-	GND*	GND*	-
I/O	6	-	-	V2	476
I/O	6	-	-	U4	482
I/O, V$_{REF}$	6	P47	N2	Y1	485
GND	-	-	GND*	GND*	-
I/O	6	-	M4	W2	488
I/O	6	-	-	V3	491
I/O	6	-	-	V4	494
I/O	6	P48	R1	Y2	500
I/O	6	P49	M3	W3	503
M1	-	P50	P2	U5	506
GND	-	P51	GND*	GND*	-
M0	-	P52	N3	AB2	507
V$_{CCO}$	6	P53	V$_{CCO}$ Bank 6*	V$_{CCO}$ Bank 6*	-
V$_{CCO}$	5	P53	V$_{CCO}$ Bank 5*	V$_{CCO}$ Bank 5*	-
M2	-	P54	R3	Y4	508
I/O	5	-	-	W5	518
I/O	5	-	-	AB3	521
I/O	5	-	N5	V7	524
GND	-	-	GND*	GND*	-
I/O, V$_{REF}$	5	P57	T2	Y6	527
I/O	5	-	-	AA4	530
I/O	5	-	-	AB4	536
I/O	5	-	P5	W6	539
I/O	5	P58	T3	Y7	542
GND	-	-	GND*	GND*	-

XC2S200 Device Pinouts *(Continued)*

Function	Bank	PQ208	FG256	FG456	Bndry Scan
V$_{CCO}$	5	-	V$_{CCO}$ Bank 5*	V$_{CCO}$ Bank 5*	-
I/O, V$_{REF}$	5	P59	T4	AA5	545
I/O	5	P60	M6	AB5	548
I/O	5	-	-	V8	551
I/O	5	-	-	AA6	554
I/O	5	-	T5	AB6	557
GND	-	-	GND*	GND*	-
I/O	5	P61	N6	AA7	560
I/O	5	-	-	W7	563
I/O, V$_{REF}$	5	P62	R5	W8	569
I/O	5	P63	P6	Y8	572
GND	-	P64	GND*	GND*	-
V$_{CCO}$	5	P65	V$_{CCO}$ Bank 5*	V$_{CCO}$ Bank 5*	-
V$_{CCINT}$	-	P66	V$_{CCINT}$*	V$_{CCINT}$*	-
I/O	5	P67	R6	AA8	575
I/O	5	P68	M7	V9	578
I/O	5	-	-	AB8	581
I/O	5	-	-	W9	584
I/O	5	-	-	AB9	587
GND	-	-	GND*	GND*	-
I/O	5	P69	N7	Y9	590
I/O	5	-	-	V10	593
I/O	5	-	-	AA9	596
I/O	5	P70	T6	W10	599
I/O	5	P71	P7	AB10	602
GND	-	P72	GND*	GND*	-
V$_{CCO}$	5	-	V$_{CCO}$ Bank 5*	V$_{CCO}$ Bank 5*	-
I/O, V$_{REF}$	5	P73	P8	Y10	605
I/O	5	P74	R7	V11	608
I/O	5	-	-	AA10	614
I/O	5	-	T7	W11	617
I/O	5	P75	T8	AB11	620
I/O	5	-	-	U11	623
V$_{CCINT}$	-	P76	V$_{CCINT}$*	V$_{CCINT}$*	-
I, GCK1	5	P77	R8	Y11	635
V$_{CCO}$	5	P78	V$_{CCO}$ Bank 5*	V$_{CCO}$ Bank 5*	-
V$_{CCO}$	4	P78	V$_{CCO}$ Bank 4*	V$_{CCO}$ Bank 4*	-
GND	-	P79	GND*	GND*	-

XC2S200 Device Pinouts *(Continued)*

XC2S200 Pad Name					Bndry Scan
Function	Bank	PQ208	FG256	FG456	
I, GCK0	4	P80	N8	W12	636
I/O	4	P81	N9	U12	640
I/O	4	-	-	V12	646
I/O	4	P82	R9	Y12	649
I/O	4	-	N10	AA12	652
I/O	4	-	-	W13	655
I/O	4	P83	T9	AB13	661
I/O, V_{REF}	4	P84	P9	AA13	664
V_{CCO}	4	-	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P85	GND*	GND*	-
I/O	4	P86	M10	Y13	667
I/O	4	P87	R10	V13	670
I/O	4	-	-	AB14	673
I/O	4	-	-	W14	676
I/O	4	P88	P10	AA14	679
GND	-	-	GND*	GND*	-
I/O	4	-	-	V14	682
I/O	4	-	-	Y14	685
I/O	4	-	-	W15	688
I/O	4	P89	T10	AB15	691
I/O	4	P90	R11	AA15	694
V_{CCINT}	-	P91	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	4	P92	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P93	GND*	GND*	-
I/O	4	P94	M11	Y15	697
I/O, V_{REF}	4	P95	T11	AB16	700
I/O	4	-	-	AB17	706
I/O	4	P96	N11	V15	709
GND	-	-	GND*	GND*	-
I/O	4	-	R12	Y16	712
I/O	4	-	-	AA17	715
I/O	4	-	-	W16	718
I/O	4	P97	P11	AB18	721
I/O, V_{REF}	4	P98	T12	AB19	724
V_{CCO}	4	-	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	-	GND*	GND*	-
I/O	4	P99	T13	Y17	727
I/O	4	-	N12	V16	730
I/O	4	-	-	AA18	733

XC2S200 Device Pinouts *(Continued)*

XC2S200 Pad Name					Bndry Scan
Function	Bank	PQ208	FG256	FG456	
I/O	4	-	-	W17	739
I/O, V_{REF}	4	P100	R13	AB20	742
GND	-	-	GND*	GND*	-
I/O	4	-	P12	AA19	745
I/O	4	-	-	V17	748
I/O	4	-	-	Y18	751
I/O	4	P101	P13	AA20	757
I/O	4	P102	T14	W18	760
GND	-	P103	GND*	GND*	-
DONE	3	P104	R14	Y19	763
V_{CCO}	4	P105	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
V_{CCO}	3	P105	V_{CCO} Bank 3*	V_{CCO} Bank 3*	-
$\overline{PROGRAM}$	-	P106	P15	W20	766
I/O ($\overline{INIT}$)	3	P107	N15	V19	767
I/O (D7)	3	P108	N14	Y21	770
I/O	3	-	-	V20	776
I/O	3	-	-	AA22	779
I/O	3	-	T15	W21	782
GND	-	-	GND*	GND*	-
I/O, V_{REF}	3	P109	M13	U20	785
I/O	3	-	-	U19	788
I/O	3	-	-	V21	794
GND	-	-	GND*	GND*	-
I/O	3	-	R16	T18	797
I/O	3	P110	M14	W22	800
GND	-	-	GND*	GND*	-
V_{CCO}	3	-	V_{CCO} Bank 3*	V_{CCO} Bank 3*	-
I/O, V_{REF}	3	P111	L14	U21	803
I/O	3	P112	M15	T20	806
I/O	3	-	-	T19	809
I/O	3	-	-	V22	812
I/O	3	-	-	L12	T21	815
GND	-	-	GND*	GND*	-
I/O	3	P113	P16	R18	818
I/O	3	-	-	U22	821
I/O, V_{REF}	3	P114	L13	R19	827
I/O (D6)	3	P115	N16	T22	830
GND	-	P116	GND*	GND*	-